

QUAD testbox

Fred Hartjes NIKHEF

Nikhef/Bonn LepCol meeting March 11, 2019

✓ Done last 2 weeks

Status testbox

- ✓ Check gas tightness, O2 and water diffusion at **5 ml/min**
 - ✓ Leaks < 0.1 ml/min
 - ✓ O2 level ~300 ppM
 - ✓ Humidity 2500 ppM
 - ✓ With higher flow (20 ppM) we can bring
 - ✓ O2 level down to < 100 ppM
 - ✓ Further down with O2 filter
 - ✓ Humidity < 1000 ppM after prolonged flushing
 - ✓ Note: chamber content ~ 780 ml
- ✓ All 8 quads tested simultaneously until 330 V
 - Initially no sparking seen
 - ✓ When testing (powering quad 13) minor discharges (< 20 nA)
- Install liquid cooling system
- Temporary DAQ with one or two SPIDR boards (lacking concentrator firmware)
- => laser setup operational (quad 13) including DAQ, laser and stage control

To be done

- Repair flex quad17
- Programming concentrator (started)



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Laser ionization is present

- Laser beam **not attenuated**
- Vgrid = -330V
- White curve is grid current
- **5** min on, 5 min blocked, 5 min on, 5 min blocked



- Current with laser beam: 0.78 nA
- => 1.6M electrons/s; 650k per shot
- Assume gain = 3000, 1500 e-/track
- => corresponding track rate ~ 1 kHz
 - But all over ~ 1 mm wide band within ~ 20 ns
- We may need ~ factor 20 laser attenuation

Test with 90Sr source



Vgrid = -330V

Test with 90Sr source



Referring to spark testbeam November 2016 at SPS



- All detectors equipped with grid and SixNy layer by Yevgen
- 200 GeV pions
- Time structure 5s on, 13 s off
- Beam rate averaged: ~ 80 kHz
- ITK gas
- Dummy detectors (solid metal plate), TPX1 and TPX3
- Beam currents during spill (all converted to 300 V)
 - **Dummy** ~ 10 nA
 - **TPX1 ~ 6 nA**
 - **TPX3 ~ 1.6 nA**





Dummy 300V (white and red) TPX1 325 V (green and blue)

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Potential buildup across protection layer

- Poole-Frenkel effect
- Conductivity higher at higher field
- Substrates Yevgen (2016?)
- Layers Delft (Violeta) ~ 20 x lower resistivity
- Latest production by Yevgen (IZM) unknown
- We have to measure a chips from the last run with the Hg probe
 - => only conductivity per mm2 is relevant for us
 - (not surface resistivity)
- We may have to enlarge the pads to reduce the charge up effect

Conductivity (J/E) vs square root electric field (E^{1/2})

substrate: 4 µm SixNy on TPX3 dummy W3; W2; W1 (Berlin) substrate: 4 µm SiXN on 1 µm Al (049.1, Delft) negative potential on layer surface measured on August 15, 2016 and Feb 7-16, 2017 Fred Hartjes, Nikhef



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Raw data gas gain curve

- Permanently irradiated with Sr-90-04
- Current averaged over ~ 4 min
- Noise on current
 - Proportional with averaged current



Gas gain curve

Induced grid current vs grid voltage



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- Nature of the current noise still unclear
- Amplitude proportional to the induced source current
- No extreme peaks
- Without source at 330V stable without any current during many hours
- Occasional minor peaks (10 20 nA) observed at powered quad
- Discharges??
- Regulation instability??
 - $7.5 \Rightarrow 15 \text{ nF capacitive load}$

Grid current stability



HV circuit 8-quad testbox

